

Welcome!
**8th International Workshop on
Combinatorial Testing (IWCT 2019)**

23 April 2019, Xian, China



IWCT previous editions

1. Montreal (2012),
2. Luxembourg (2013),
3. Cleveland (2014),
4. Graz (2015),
5. Chicago (2016),
6. Tokyo (2017),
7. Vasteras (2018),
8. This year Xian

Number submissions and reviews

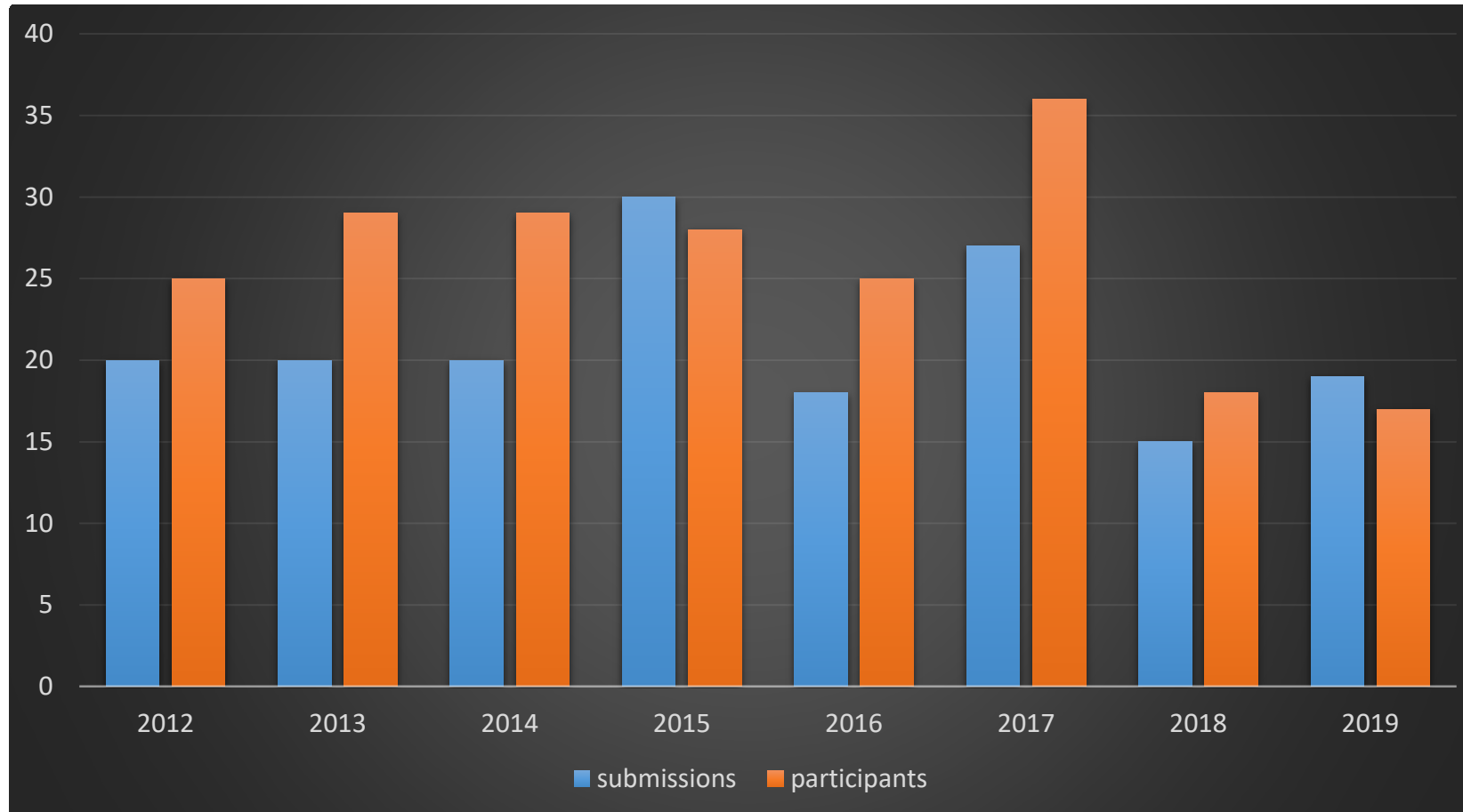
- This year we received 19 submissions, from which 14 papers (6 full, 6 short ones) + 2 extended abstract were accepted for publication.

Submissions	19 (+4)
Accepted	14 (+3)
Acceptance rate	0.74 (+0.01)
Reviews	59 (+10)
External reviewers	5 (+4)
External reviews	7 (+5)

Reviewing

reviews for a paper	number of papers
3	14
4	4

IWCT in these years



Organization

Program Co-chairs

- Dimitris Simos, SBA Research, Austria
- Yu Lei, University of Texas Arlington, USA

Organizing Committee

- Jacek Czerwonka Microsoft Research, USA
- Angelo Gargantini, University of Bergamo, Italy
- George Sherwood, Testcover.com, USA
- Rachel Tzoref-Brill, IBM Research, Israel

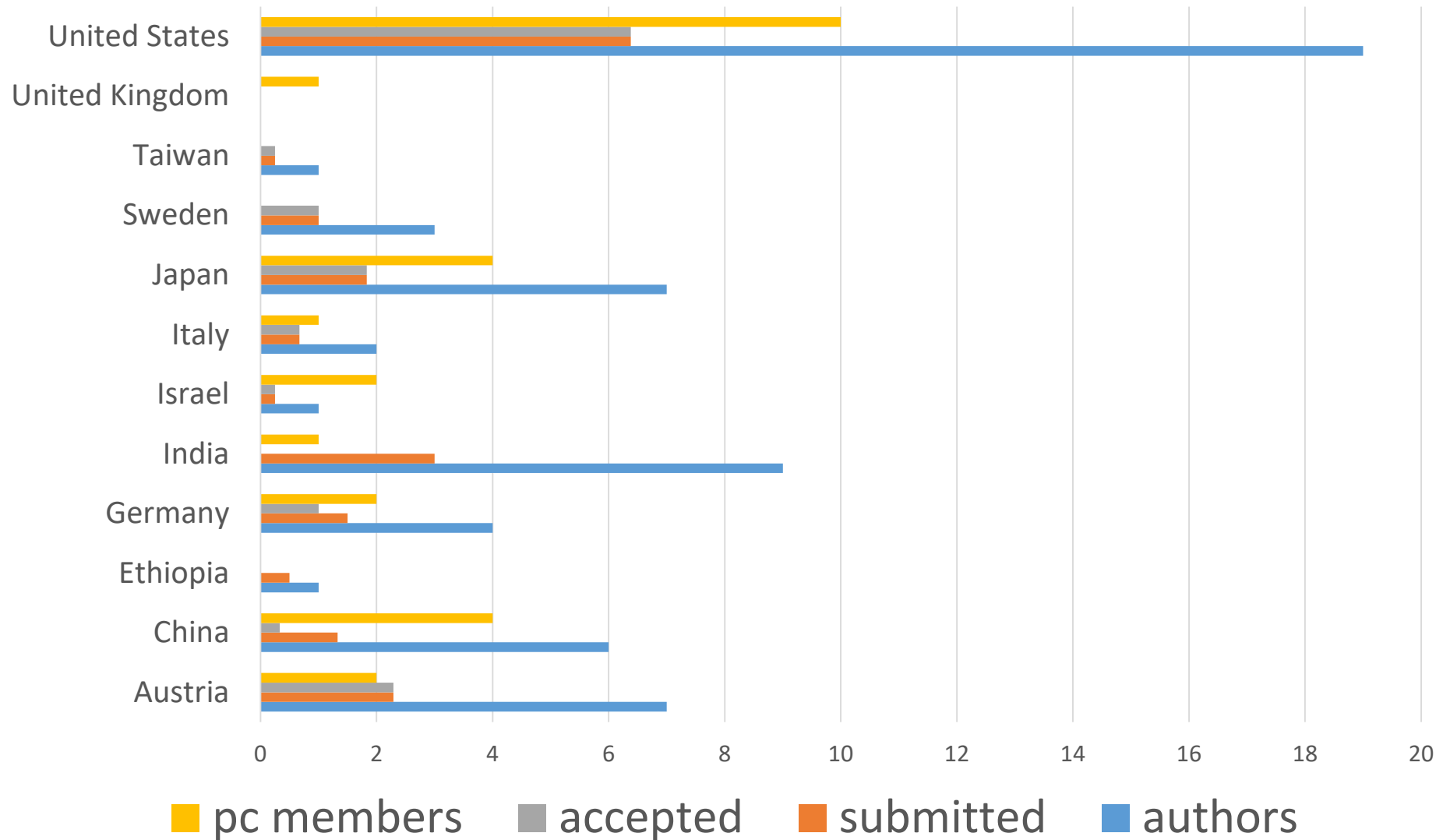
Steering Committee

- Raghu Kacker, NIST, Gaithersburg, MD USA
- Richard Kuhn, NIST, Gaithersburg, MD USA
- Itai Segall, Alcatel-Lucent Bell Labs, Tel Aviv, Israel

Program Committee

- Keizo Tatsumi Fujitsu LTD & ASTER, Japan
- Myra Cohen University of Nebraska-Lincoln, USA
- Charles Colbourn Arizona State University, USA
- Franz Wotawa Institute for Software Technology, TU Graz, Austria
- Changhai Nie Dept. of Computer Science and Technology, Nanjing University, China
- Krishnan Rangarajan, Dayananda Sagar College of Engineering, Bangalore, India
- Chek Pin Yang University of Warwick, UK
- Jim Lawrence George Mason University, USA
- Jian Zhang Institute of Software, Chinese Academy of Sciences, China
- Peter Zimmerer Siemens AG, Germany
- Ziyuan Wang, Nanjing University of Posts and Telecommunications, China
- Akihisa Yamada National Institute of Informatics, Japan
- Mohammad Raunak Loyola University Maryland, USA
- Takashi Kitamura Information Technology Research Institute, AIST, Japan
- Peter Kruse, Berner & Mattner, Germany
- Murat Ozcan, Siemens Industry Inc., USA
- Tatsuhiro Tsuchiya Osaka University, Japan
- Huayao Wu Dept. of Computer Science and Technology, Nanjing University, China

Countries



Program

- **Opening Remarks: Welcome to IWCT** 08:50 – 09:00
- **Full Paper Session 1: Modelling and Tools** 09:00 – 10:00
- **Coffee break** 10:00 – 10:30
- **Full Paper Session 2: Test Generation, Constraints and Fault Localization** 10:30 - 12:30
- **Lunch** 12:30 – 13:30
- **Short Paper Session 1: Measurement and Test Reduction** 13:30-14:30
- **Short Paper Session 2: Practical Applications** 14:30 – 15:30
- **Coffee break** 15:30 – 16:00
- **Poster Session 15:30 – 16:30** , starting on coffee break
- *IWCT Organizing & Steering Committee Meeting:* 16:30-17:30
- **Dinner?**

Thank you for making this workshop a success

Dimitris Simos

- SBA Research, Vienna, Austria



Jeff Yu Lei

- University of Texas at Arlington, USA

